

74HCT4051D, 74HCT4052D

1. Functional Description

74HCT4051D: 8-Channel Analog Multiplexer/Demultiplexer

74HCT4052D: Dual 4-Channel Analog Multiplexer/Demultiplexer

2. General

The 74HCT4051D/74HCT4052D are high speed CMOS ANALOG MULTIPLEXER/DEMULTIPLEXER fabricated with silicon gate C²MOS technology. They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. This inputs are compatible with TTL, NMOS and CMOS output voltage levels.

The 74HCT4051D has an 8 channel configuration and the 74HCT4052D has a 4 channel × 2 configuration.

The digital signal to the control terminal turns "ON" the corresponding switch of each channel a large amplitude signal ($V_{CC} - V_{EE}$) can then be switched by the small logical amplitude ($V_{CC} - GND$) control signal.

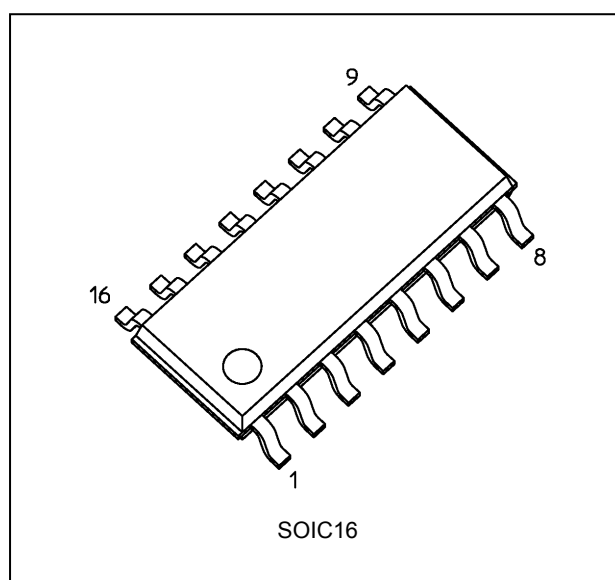
For example, in the case of $V_{CC} = 5\text{ V}$, $GND = 0\text{ V}$, $V_{EE} = -5\text{ V}$, signals between -5 V and $+5\text{ V}$ can be switched from the logical circuit with a single power supply of 5 V . As the ON-resistance of each switch is low, they can be connected to circuits with low input impedance.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

3. Features

- (1) Low power dissipation: $I_{CC} = 4.0\text{ }\mu\text{A}$ (max) ($V_{CC} = 5.5\text{ V}$, $V_{EE} = GND$, $T_a = 25\text{ }^\circ\text{C}$)
- (2) Compatible with TTL output: $V_{IH} = 2.0\text{ V}$ (min), $V_{IL} = 0.8\text{ V}$ (max)
- (3) Wide interfacing ability: LSTTL, NMOS, CMOS
- (4) Low ON-resistance: $R_{ON} = 135\text{ }\Omega$ (typ. $V_{IN} = V_{EE}$), $75\text{ }\Omega$ (typ. $V_{IN} = V_{CC}$) at $V_{CC} - V_{EE} = 9\text{ V}$
- (5) High noise immunity: THD = 0.020 % (typ.) at $V_{CC} - V_{EE} = 9\text{ V}$

4. Packaging

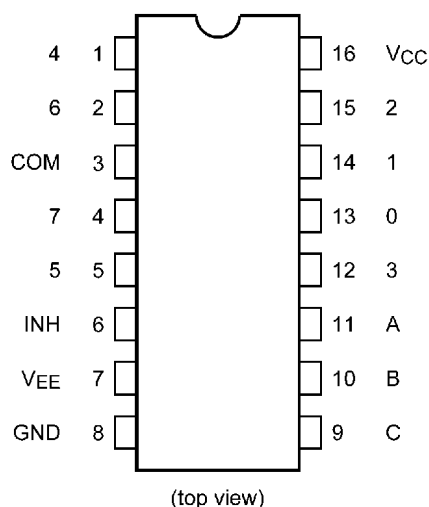


Start of commercial production

2016-04

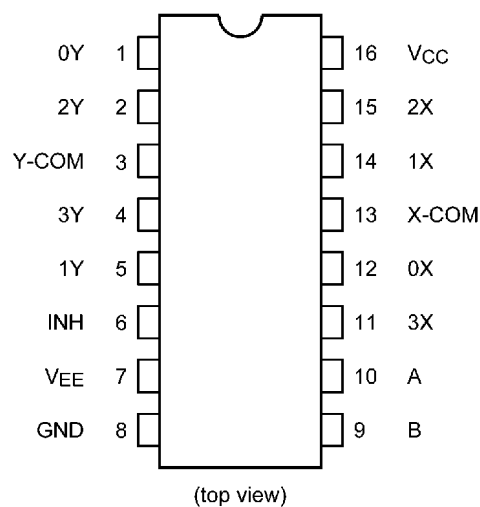
5. Pin Assignment

74HCT4051D



(top view)

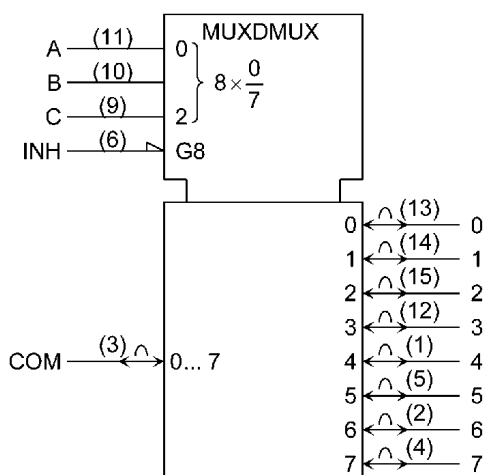
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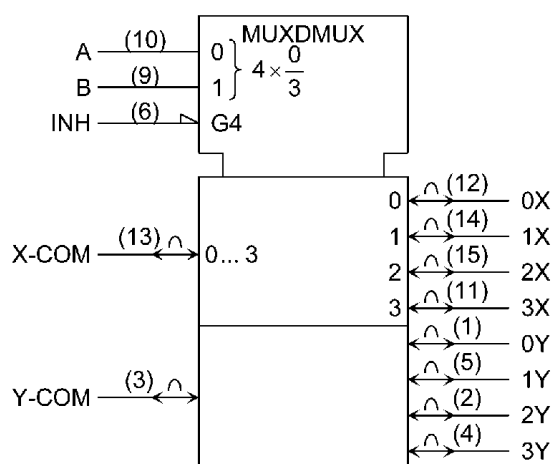
(top view)

6. IEC Logic Symbol

74HCT4051D

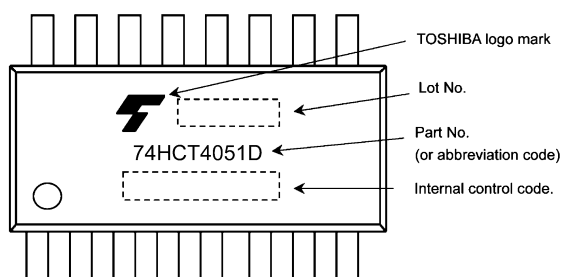


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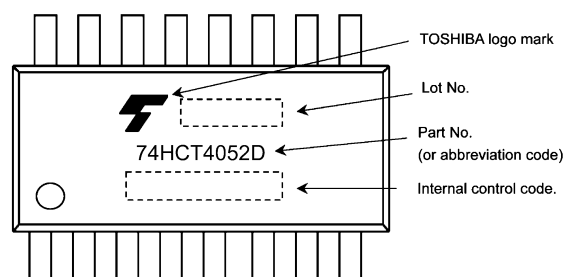


7. Marking

74HCT4051D

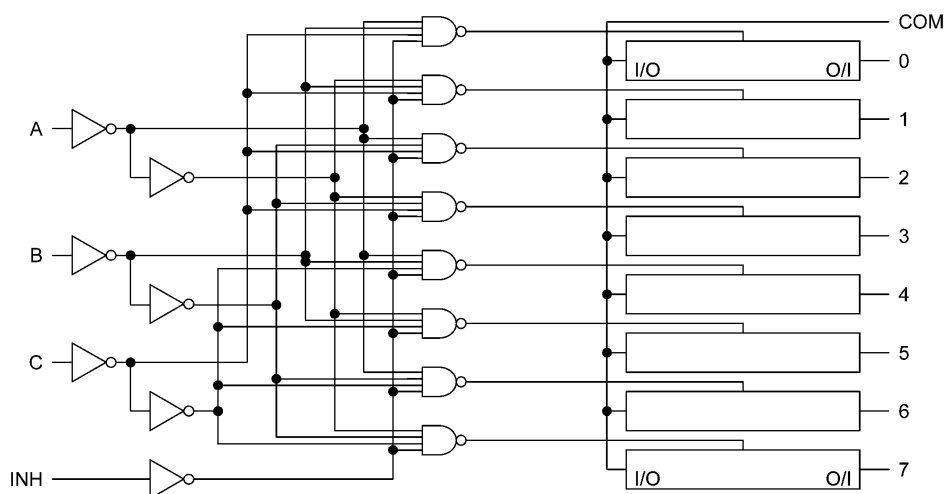


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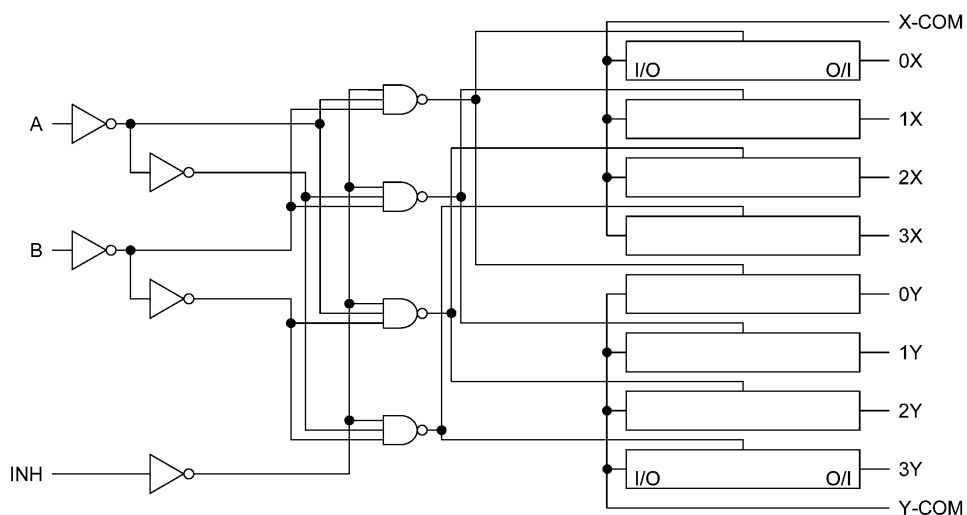


8. System Diagram

74HCT4051D



74HCT4052D



9. Truth Table

Input Inhibit	Input C*	Input B	Input A	ON Channel 74HC4051D	ON Channel 74HC4052D
L	L	L	L	0	0X, 0Y
L	L	L	H	1	1X, 1Y
L	L	H	L	2	2X, 2Y
L	L	H	H	3	3X, 3Y
L	H	L	L	4	—
L	H	L	H	5	—
L	H	H	L	6	—
L	H	H	H	7	—
H	X	X	X	None	None

X: Don't care

*: Except 74HC4052D

10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	-0.5 to 7.0	V
Supply voltage	V_{EE}	-7.0 to 0	V
Supply voltage	$V_{CC}-V_{EE}$	-0.5 to 13.0	V
Input voltage	V_{IN}	-0.5 to $V_{CC} + 0.5$	V
Switch I/O voltage	$V_{I/O}$	$V_{EE} - 0.5$ to $V_{CC} + 0.5$	V
Input diode current	I_{IK}	± 20	mA
I/O diode current	$I_{I/O K}$	± 20	mA
Switch through current	I_T	± 25	mA
V_{CC} /ground current	I_{CC}	± 50	mA
Power dissipation	P_D	500	mW
Storage temperature	T_{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

11. Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	4.5 to 5.5	V
Supply voltage	V_{EE}	-6.0 to 0	V
Supply voltage	$V_{CC}-V_{EE}$	4.5 to 11.0	V
Input voltage	V_{IN}	0 to V_{CC}	V
Switch I/O voltage	$V_{I/O}$	V_{EE} to V_{CC}	V
Operating temperature	T_{opr}	-40 to 85	°C
Input rise and fall times	t_r, t_f	0 to 50	μs

Note: The operating ranges must be maintained to ensure the normal operation of the device.
Unused inputs must be tied to either V_{CC} or GND.

12. Electrical Characteristics

12.1. DC Characteristics (Unless otherwise specified, $T_a = 25\text{ }^{\circ}\text{C}$)

Characteristics	Symbol	Test Condition	V_{EE} (V)	V_{CC} (V)	Min	Typ.	Max	Unit
High-level input voltage	V_{IH}	—		4.5 to 5.5	2.0	—	—	V
Low-level input voltage	V_{IL}	—		4.5 to 5.5	—	—	0.8	V
ON-resistance	R_{ON}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC} \text{ to } V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	180	240	Ω
			-4.5	4.5	—	140	190	
			-5.5	5.5	—	135	180	
ON-resistance		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	150	200	
			-4.5	4.5	—	135	170	
			-5.5	5.5	—	125	170	
ON-resistance		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	95	130	
			-4.5	4.5	—	75	100	
			-5.5	5.5	—	70	100	
Difference of ON-resistance between switches	ΔR_{ON}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC} \text{ to } V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	4	5	Ω
			-4.5	4.5	—	3	4	
			-5.5	5.5	—	3	4	
Input/Output leakage current (Switch OFF)	I_{OFF}	$V_{OS} = V_{CC} \text{ or } GND$ $V_{IS} = GND \text{ or } V_{CC}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	5.5	—	—	± 0.06	μA
			-5.5	5.5	—	—	± 0.1	
Input/Output leakage current (Switch ON)	I_{IO}	$V_{OS} = V_{CC} \text{ or } GND$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	5.5	—	—	± 0.06	μA
			-5.5	5.5	—	—	± 0.1	
Control input leakage current	I_{IN}	$V_{IN} = V_{CC} \text{ or } GND$	GND	5.5	—	—	± 0.1	μA
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC} \text{ or } GND$	GND	5.5	—	—	4.0	μA
			-5.5	5.5	—	—	8.0	

12.2. DC Characteristics (Unless otherwise specified, $T_a = -40 \text{ to } 85\text{ }^{\circ}\text{C}$)

Characteristics	Symbol	Test Condition	V_{EE} (V)	V_{CC} (V)	Min	Max	Unit
High-level input voltage	V_{IH}	—		4.5 to 5.5	2.0	—	V
Low-level input voltage	V_{IL}	—		4.5 to 5.5	—	0.8	V
ON-resistance	R_{ON}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC} \text{ to } V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	300	Ω
			-4.5	4.5	—	240	
			-5.5	5.5	—	225	
ON-resistance		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	250	
			-4.5	4.5	—	215	
			-5.5	5.5	—	215	
ON-resistance		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	165	
			-4.5	4.5	—	125	
			-5.5	5.5	—	125	
Difference of ON-resistance between switches	ΔR_{ON}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{IO} = V_{CC} \text{ to } V_{EE}$ $I_{IO} \leq 2\text{ mA}$	GND	4.5	—	—	Ω
			-4.5	4.5	—	—	
			-5.5	5.5	—	—	
Input/Output leakage current (Switch OFF)	I_{OFF}	$V_{OS} = V_{CC} \text{ or } GND$ $V_{IS} = GND \text{ or } V_{CC}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	5.5	—	± 0.6	μA
			-5.5	5.5	—	± 1.0	
Input/Output leakage current (Switch ON)	I_{IO}	$V_{OS} = V_{CC} \text{ or } GND$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	GND	5.5	—	± 0.6	μA
			-5.5	5.5	—	± 1.0	
Control input leakage current	I_{IN}	$V_{IN} = V_{CC} \text{ or } GND$	GND	5.5	—	± 1.0	μA
Quiescent supply current	I_{CC}	$V_{IN} = V_{CC} \text{ or } GND$	GND	5.5	—	40.0	μA
			-5.5	5.5	—	80.0	

12.3. AC Characteristics

(Unless otherwise specified, $C_L = 50 \text{ pF}$, $T_a = 25 \text{ }^\circ\text{C}$, Input: $t_r = t_f = 6 \text{ ns}$)

Characteristics	Part Number	Symbol	Test Condition	V_{EE} (V)	V_{CC} (V)	Min	Typ.	Max	Unit
Phase difference between input to output		$\phi_{I/O}$	—	GND	4.5	—	7	12	ns
				GND	5.5	—	6	10	
				-4.5	4.5	—	5	—	
Output enable time	74HCT4051D	t_{PZL}, t_{PZH}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	30	45	ns
				GND	5.5	—	26	35	
				-4.5	4.5	—	25	35	
	74HCT4052D		$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	30	45	ns
				GND	5.5	—	26	35	
				-4.5	4.5	—	25	35	
Output disable time	74HCT4051D	t_{PLZ}, t_{PHZ}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	22	30	ns
				GND	5.5	—	21	28	
				-4.5	4.5	—	21	28	
	74HCT4052D		$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	22	30	ns
				GND	5.5	—	21	28	
				-4.5	4.5	—	21	28	
Control input capacitance		C_{IN}	—	—	—	—	5	10	pF
Common terminal capacitance	74HCT4051D	C_{IS}	Figure 2	-5.0	5.0	—	36	70	pF
	74HCT4052D					—	19	40	
Switch terminal capacitance	74HCT4051D	C_{OS}	Figure 2	-5.0	5.0	—	7	15	pF
	74HCT4052D					—	7	15	
Feedthrough capacitance	74HCT4051D	C_{IOS}	Figure 2	-5.0	5.0	—	0.75	2	pF
	74HCT4052D					—	0.75	2	
Power dissipation capacitance	74HCT4051D	C_{PD}	Figure 2 (Note 1)	GND	5.0	—	70	—	pF
	74HCT4052D					—	71	—	

Note 1: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

$$I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}$$

**12.4. AC Characteristics (Unless otherwise specified, $C_L = 50 \text{ pF}$, $T_a = -40 \text{ to } 85 \text{ }^\circ\text{C}$,
Input: $t_r = t_f = 6 \text{ ns}$)**

Characteristics	Part Number	Symbol	Test Condition	V_{EE} (V)	V_{CC} (V)	Min	Max	Unit
Phase difference between input to output	74HCT4051D	$\phi_{I/O}$	—	GND	4.5	—	15	ns
				GND	5.5	—	13	
				-4.5	4.5	—	—	
Output enable time	74HCT4051D	t_{PZL}, t_{PZH}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	55	ns
				GND	5.5	—	42	
				-4.5	4.5	—	41	
	74HCT4052D	t_{PZL}, t_{PZH}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	55	ns
				GND	5.5	—	42	
				-4.5	4.5	—	41	
Output disable time	74HCT4051D	t_{PLZ}, t_{PHZ}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	37	ns
				GND	5.5	—	34	
				-4.5	4.5	—	34	
	74HCT4052D	t_{PLZ}, t_{PHZ}	$R_L = 1 \text{ k}\Omega$ Figure 1	GND	4.5	—	37	ns
				GND	5.5	—	34	
				-4.5	4.5	—	34	
Control input capacitance		C_{IN}	—	—	—	—	10	pF
Common terminal capacitance	74HCT4051D	C_{IS}	Figure 2	-5.0	5.0	—	70	pF
	74HCT4052D					—	40	
Switch terminal capacitance	74HCT4051D	C_{OS}	Figure 2	-5.0	5.0	—	15	pF
	74HCT4052D					—	15	
Feedthrough capacitance	74HCT4051D	C_{IOS}	Figure 2	-5.0	5.0	—	2	pF
	74HCT4052D					—	2	

12.5. Analog Switch Characteristics (T_a = 25 °C) (Note)

Characteristics	Part Number	Symbol	Test Condition		V _{EE} (V)	V _{CC} (V)	Typ.	Unit
Sine Wave Distortion		THD	R _L = 10 kΩ, C _L = 50 pF f _{IN} = 1 kHz	V _{IN} = 8.0 V _{p-p}	-4.5	4.5	0.020	%
				V _{IN} = 11.0 V _{p-p}	-5.5	5.5	0.019	
Maximum frequency response		f _{MAX(I/O)}	Adjust f _{IN} voltage to obtain 0 dBm at V _{OS} Increase f _{IN} frequency until dB meter reads -3 dB R _L = 50 Ω, C _L = 10 pF f _{IN} = 1 MHz, sine wave Figure 3	(Note 1)	-4.5	4.5	190	MHz
	(Note 2)			70				
				110				
				(Note 1)	-5.5	5.5	200	
	74HCT4051D			(Note 2)			80	
	74HCT4052D						135	
Feed through attenuation (switch OFF)		FTH	V _{IN} is centered at (V _{CC} /2). Adjust input for 0 dBm. R _L = 600 Ω, C _L = 50 pF, f _{IN} = 1 MHz, sine wave Figure 4		-4.5	4.5	-50	dB
					-5.5	5.5	-50	
Crosstalk (control input to signal output)		X _{talk}	R _L = 600 Ω, C _L = 50 pF, f _{IN} = 1 MHz, square wave (t _r = t _f = 6 ns) Figure 5		-4.5	4.5	140	mV
					-5.5	5.5	180	
Crosstalk (between any switches)		X _{talk}	Adjust V _{IN} to obtain 0 dBm at input. R _L = 600 Ω, C _L = 50 pF, f _{IN} = 1 MHz, sine wave Figure 6		-4.5	4.5	-50	dB
					-5.5	5.5	-50	
			R _L = 50 Ω, C _L = 15 pF, f _{IN} = 100 kHz, V _{SWITCH} = 1 V _{RMS}		-4.5	4.5	-90	

Note: These characteristics are determined by design of devices.

Note 1: Input COMMON terminal, and measured at SWITCH terminal.

Note 2: Input SWITCH terminal, and measured at COMMON terminal.

13. AC Test Circuit

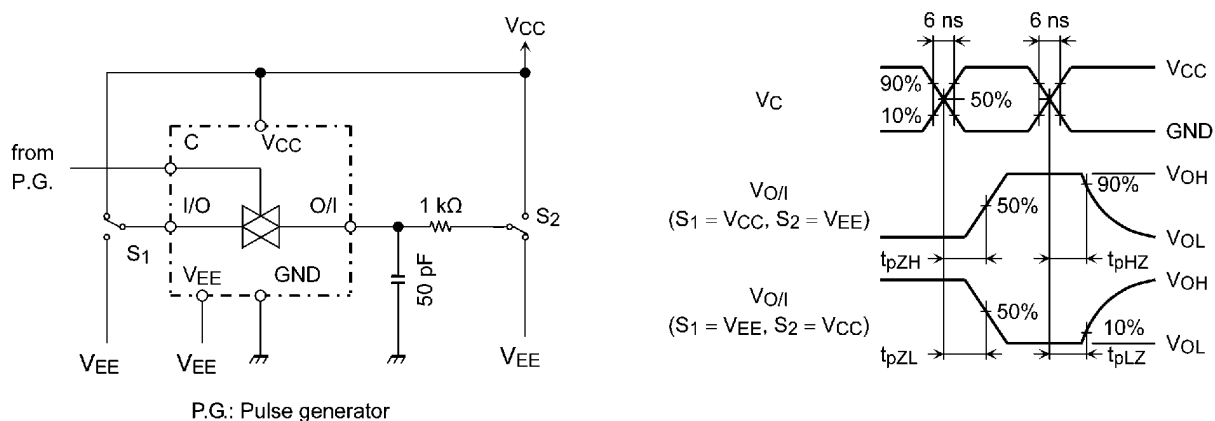


Figure 1 t_{PLZ} , t_{PHZ} , t_{PZL} , t_{PZH}

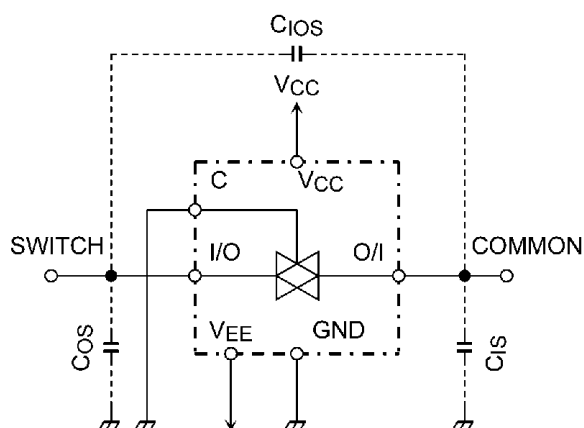


Figure 2 C_{ios} , C_{is} , C_{os}

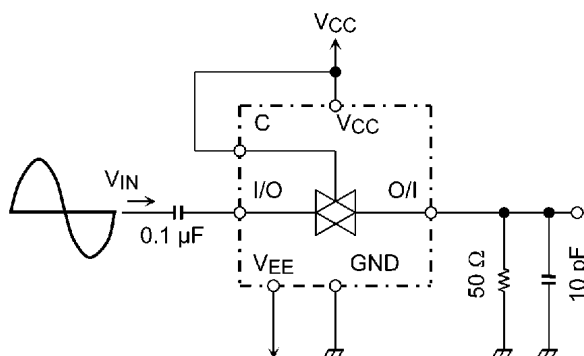


Figure 3 Frequency Response

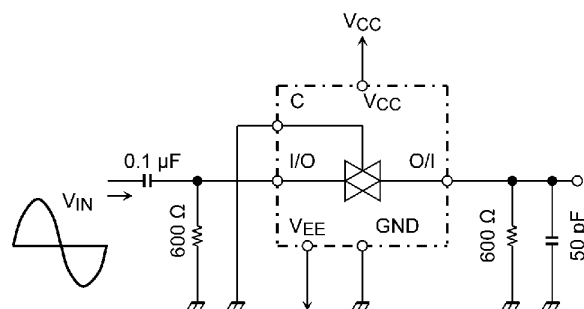
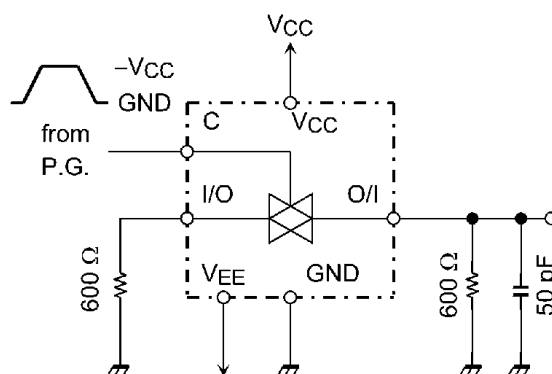


Figure 4 Feedthrough Attenuation



P.G.: Pulse generator

Figure 5 Cross Talk (control input to output signal)

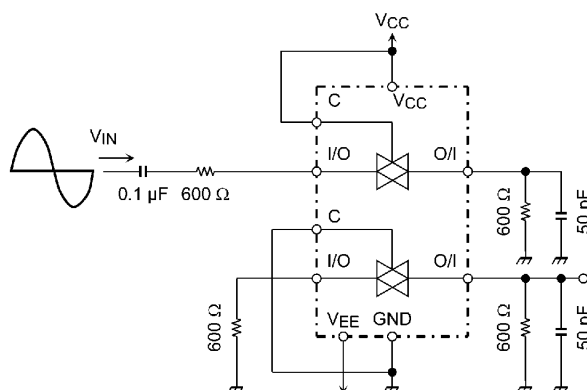
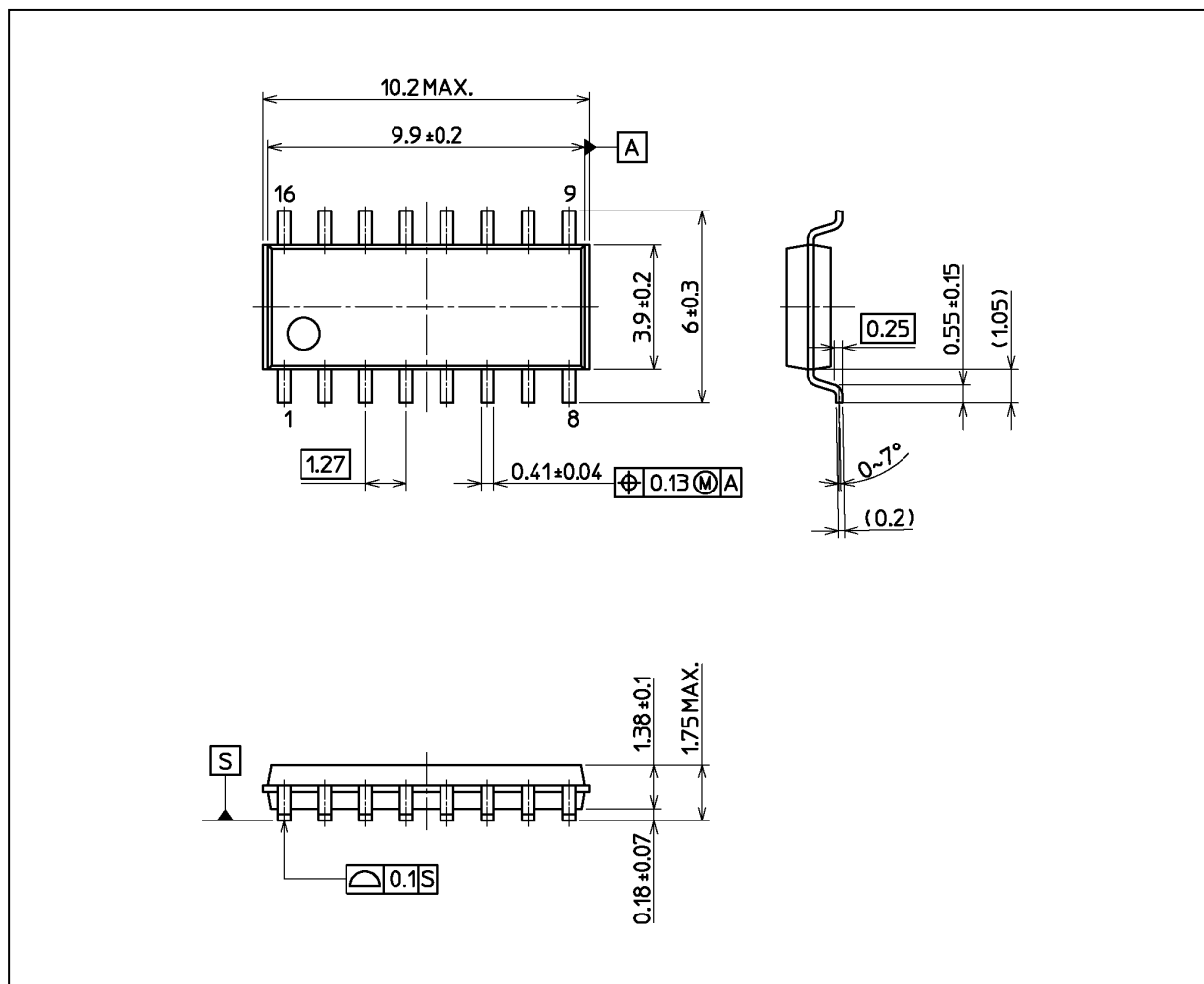


Figure 6 Cross Talk (between any two switches)

Package Dimensions

Unit: mm



Weight: 0.15 g (typ.)

Package Name(s)
Nickname: SOIC16

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